

Enhancement Mode N-Channel Power MOSFET

SOT23/NMOS/40V/ \pm 20V/1.6V/6A/18m Ω

Rev_{0.7}





40V, 18mΩ, 6A, Single N-Channel

1.Features

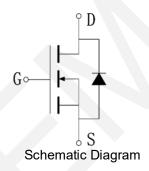
- ♦ 40V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±20V

2.A	aa	lica	tions

- ◆ Power Switching Application
- Load Switching



V _{DS}	R _{DS(on)} Typ.	I _D Max.	
40V	18mΩ @ 10V	6.4	
	23mΩ @ 4.5V	6A	



3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP4006KSS	4006K	SOT23	3,000	180,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units	
Drain to Source Voltage	$V_{ extsf{DSS}}$	40	V	
Gate to Source Voltage	V_{GSS}	±20	V	
Drain Current (DC)	I _D	6	А	
Drain Current (Pulse), PW≤300μs	I _{DP}	24	А	
Total Dissipation	P _D	1.3	W	
Junction Temperature	Tj	150	°C	
Storage Temperature	T _{stg}	-55 to +150	°C	

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	$R_{ hetaJA}$	100	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

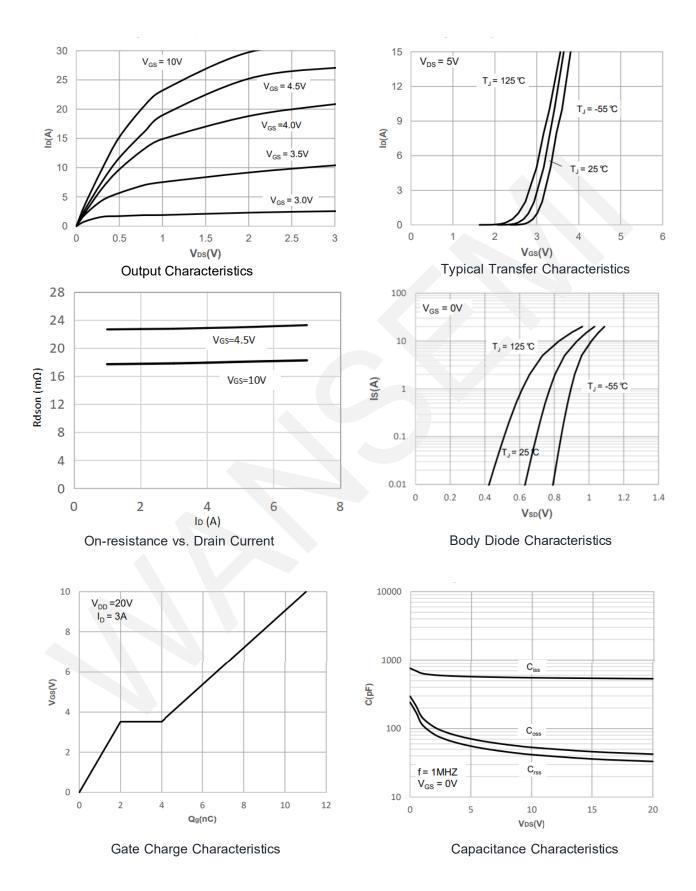
6.Electrical Characteristics at Ta=25°C (Note 3)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A, V_{GS} = 0 V$	40		-	V
Zero-Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 40V, V_{GS} = 0V$	-		1	μA
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 20V$, $V_{DS} = 0V$	ı	1	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _{DS} =250μA	1.0	1.6	2.5	V
Static Drain to Source On-State	Б	I _D = 5.5A, V _{GS} = 10V	-	18	25	mΩ
Resistance	R _{DS(on)}	I _D = 4.5A, V _{GS} = 4.5V	-	23	35	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,	-	536	-	pF
Output Capacitance	C _{oss}	V _{DS} =20V,	-	42	-	pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz	-	33	-	pF
Turn-ON Delay Time	t _{d(on)}		ı	4	-	ns
Rise Time	t _r	$V_{DS} = 20V, I_{D} = 3A$	-	2	-	ns
Turn-OFF Delay Time	$t_{d(off)}$	V_{GS} = 10V, R_G = 3 Ω	-	15	-	ns
Fall Time	t _f		-	2	-	ns
	Q_g	V _{DS} = 20V,	-	11	-	nC
Total Gate Charge	Q _{gs}	$V_{GS} = 10V$, $I_D = 3A$	-	2	-	nC
	Q_{gd}		-	2	-	nC
Diode Forward Voltage	V_{FSD}	I _S = 6A, V _{GS} = 0V	0.4	-	1.4	V

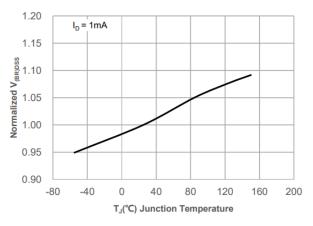
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



7. Typical Electrical and Thermal Characteristics

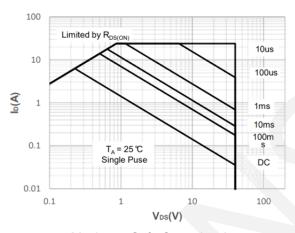




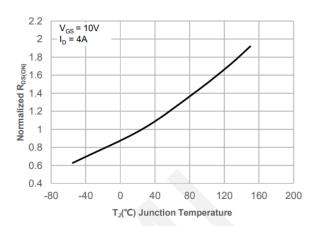


Normalized Breakdown Voltage vs.

Junction Temperature

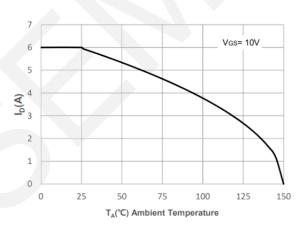


Maximum Safe Operating Area



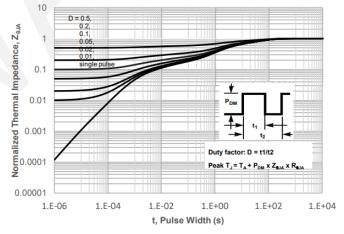
Normalized on Resistance vs.

Junction Temperature



Maximum Continuous Drain Current vs.

Case Temperature

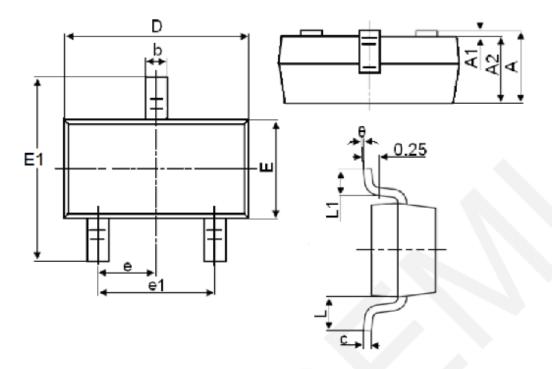


Maximum Effective Transient

Thermal Impedance, Junction-to-Case



8.Package Dimensions



Symbol	Dimensions in Millimeters				
	MIN.	TYP.	MAX.		
А	0.900		1.150		
A1	0.000		0.100		
A2	0.900		1.050		
b	0.300		0.500		
С	0.080		0.150		
D	2.800		3.000		
E	1.200		1.400		
E1	2.250		2.550		
е		0.950			
e1	1.800		2.000		
L		0.550			
L1	0.300		0.500		
θ	0°		8°		



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